

Technical Data

# **RF LDMOS Integrated Power Amplifier**

The MW6IC2420NB integrated circuit is designed with on-chip matching that makes it usable at 2450 MHz. This multi-stage structure is rated for 26 to 32 Volt operation and covers all typical industrial, scientific and medical modulation formats.

## **Driver Applications**

- Typical CW Performance at 2450 MHz:  $V_{DD}$  = 28 Volts,  $I_{DQ1}$  = 210 mA,  $I_{DQ2}$  = 370 mA,  $P_{out}$  = 20 Watts Power Gain — 19.5 dB
  - Power Added Efficiency 27%
- Capable of Handling 3:1 VSWR, @ 28 Vdc, 2170 MHz, 20 Watts CW Output Power
- Stable into a 3:1 VSWR. All Spurs Below –60 dBc @ 100 mW to 10 Watts CW  $\mathsf{P}_{out}.$

## Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source Scattering Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >3 Ohm Output)
- Integrated Quiescent Current Temperature Compensation with Enable/Disable Function <sup>(1)</sup>
  - Integrated ESD Protection
  - 225°C Capable Plastic Package

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RoHS Compliant

V<sub>DS1</sub>

RFin

V<sub>GS1</sub>

V<sub>GS2</sub>

V<sub>DS1</sub>

In Tape and Reel. R1 Suffix = 500 Units, 44 mm Tape Width, 13 inch Reel

Quiescent Current

Temperature Compensation (1)

Figure 1. Functional Block Diagram



 Refer to AN1977, Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family and to AN1987, Quiescent Current Control for the RF Integrated Circuit Device Family. Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1977 or AN1987.

2450 MHz, 20 W, 28 V CW RF LDMOS INTEGRATED POWER AMPLIFIER

Document Number: MW6IC2420N

MW6IC2420NBR1

Rev. 3, 12/2010

**√RoHS** 



CASE 1329-09 TO-272 WB-16 PLASTIC





## Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-0.5, +68	Vdc
Gate-Source Voltage	V <sub>GS</sub>	-0.5, +6	Vdc
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Case Operating Temperature	T <sub>C</sub>	150	°C
Operating Junction Temperature (1,2)	TJ	225	°C
Input Power	P <sub>in</sub>	23	dBm

#### **Table 2. Thermal Characteristics**

(	Symbol	Value <sup>(2,3)</sup>	Unit	
Thermal Resistance, Junction to	$R_{\theta JC}$		°C/W	
W-CDMA Application         Stage 1, 28 Vdc, I <sub>DQ</sub> = 210 mA           (P <sub>out</sub> = 4.5 W Avg.)         Stage 2, 28 Vdc, I <sub>DQ</sub> = 370 mA			1.8 1	

#### **Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	1A (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	III (Minimum)

#### Table 4. Moisture Sensitivity Level

L	Test Methodology	Rating	Package Peak Temperature	Unit
	Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

## Table 5. Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Functional Tests (In Freescale Wideband 2110-2170 MHz Test Fixtu P <sub>out</sub> = 4.5 W Avg., f1 = 2157.5 MHz, f2 = 2167.5 MHz, 2-Carrier W-C 3.84 MHz Channel Bandwidth @ ±5 MHz Offset. IM3 measured in 3.8 PAR = 8.5 dB @ 0.01% Probability on CCDF.	DMA, 3.84 MHz Ch	annel Bandw	idth Carriers.	ACPR measure	ured in
Power Gain	G <sub>ps</sub>	25.5	28	30	dB
Power Added Efficiency	PAE	13.7	15	_	%
Intermodulation Distortion	IM3		-43	-40	dBc
Adjacent Channel Power Ratio	ACPR		-46	-43	dBc
Input Return Loss	IRL		-15	-10	dB

1. Continuous use at maximum temperature will affect MTTF.

 MTTF calculator available at <u>http://www.freescale.com/rf</u>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

 Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to <u>http://www.freescale.com/rf</u>. Select Documentation/Application Notes - AN1955.

(continued)



Symbol	Min	Тур	Max	Unit
28 Vdc, I <sub>DQ1</sub> =	210 mA, I <sub>DQ2</sub>	2 = 370 mA, 2	2110-2170 MI	Ηz
VBW	_	30	_	MHz
Δl <sub>QT</sub>	—	±5	_	%
G <sub>F</sub>	—	0.2	_	dB
Φ	—	2	_	0
Delay	—	2.8	_	ns
$\Delta \Phi$	—	18	_	0
ed)				
Symbol	Min	Тур	Мах	Unit
28 Vdc, I <sub>DQ1</sub> =	110 mA, I <sub>DQ2</sub>	2 = 370 mA, 2	2110-2170 MH	·Ιz
P <sub>sat</sub>	—	60	_	W
	28 Vdc, $I_{DQ1} = 2$ 28 Vdc, $I_{DQ1} = 2$ VBW $\Delta I_{QT}$ $G_F$ $\Phi$ Delay $\Delta \Phi$ ed) Symbol 28 Vdc, $I_{DQ1} = 2$	28 Vdc, $I_{DQ1} = 210 \text{ mA}, I_{DQ2}$ 28 Vdc, $I_{DQ1} = 210 \text{ mA}, I_{DQ2}$ VBW $\Delta I_{QT}$ $\Delta I_{QT}$ $\Phi$ $\Phi$ Delay $\Delta \Phi$ $\Delta \Phi$ Delay         Delay $\Delta \Phi$ Delay         Delay $\Delta \Phi$ Delay $\Delta \Phi$ Delay $\Delta \Phi$ $\Delta \Phi$ $\Delta \Phi$ $\Delta \Phi$ $\Delta \Phi$ $\Delta \Phi$	28 Vdc, $I_{DQ1} = 210 \text{ mA}, I_{DQ2} = 370 \text{ mA}, 2$ 28 Vdc, $I_{DQ1} = 210 \text{ mA}, I_{DQ2} = 370 \text{ mA}, 2$ VBW       —       30 $\Delta I_{QT}$ —       30 $\Delta I_{QT}$ —       2 $G_F$ —       0.2 $\Phi$ —       2         Delay       —       2.8 $\Delta \Phi$ —       18         ed)       Symbol       Min       Typ         28 Vdc, $I_{DQ1} = 110 \text{ mA}, I_{DQ2} = 370 \text{ mA}, 2       370 \text{ mA}, 2   $	28 Vdc, $I_{DQ1} = 210 \text{ mA}, I_{DQ2} = 370 \text{ mA}, 2110-2170 \text{ MH}$ VBW       -       30 $\Delta I_{QT}$ - $\pm 5$ $G_F$ -       0.2 $\Phi$ -       2          Delay       -       2.8 $\Delta \Phi$ -       18          ed)       Symbol       Min       Typ       Max

#### Table 5. Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise noted) (continued)

 Refer to AN1977, Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family and to AN1987, Quiescent Current Control for the RF Integrated Circuit Device Family. Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1977 or AN1987.

Select Documentation/Application Notes - AN1977 or AN

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=		-	$\underline{\underline{I}}_{\underline{L}}^{C4}$ $\underline{\underline{I}}_{\underline{L}}^{C12}$	C,
NC -	C13 =			0
Z1	0.510″ x 0.054″ Microstrip	Z6	0.189″ x 0.237″ Microstrip	
Z2	0.300" x 0.054" Microstrip	Z7	0.127" x 0.054" Microstrip	
Z3, Z8	0.410" x 0.054" Microstrip	Z9	0.182" x 0.054" Microstrip	
Z4	0.138" x 0.237" Microstrip	Z10, Z11	1.073" x 0.054" Microstrip	U,
Z5	0.086" x 0.237" Microstrip	PCB	Taconic RF35, 0.020", $\epsilon_r=3.5$	- L-
Fig	gure 3. MW6IC2420NBR1 Te	st Circuit Sche	ematic — 2450 MHz	C.
	t Circuit Component Desig		_	

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Z10

Z11

Z5

16

14 Z4

NC 13

12

NC 15

DUT

Quiescent Current

Temperature

Compensation

 $< V_{DS2}$ 

Ζ7

C8

Z9

C10

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Z8

<u>T</u>C9

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-C6

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Z6

able 7. MW6IC2420NBR	1 Test Circuit	Component	Designations a	nd Values

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⊥ ⊥⊑<sup>c1</sup>

Z2

V<sub>GS1</sub>

V<sub>GS2</sub> R2 NC

ĪC3

Z3

1 2

3 NC NC 4

5

6

7 NC

8

9

10 

Part	Description	Part Number	Manufacturer
C1, C2, C3, C4	2.2 µF Chip Capacitors	C32225X5R1H225MT	TDK
C5, C13	100 nF Chip Capacitors	C1206C104K1KAC	Kemet
C6, C7	0.5 pF Chip Capacitors	08051J0R5BS	AVX
 C8	6.8 pF Chip Capacitor	08051J6R8BS	AVX
C9	2.2 pF Chip Capacitor	08051J2R2BS	AVX
C10	1 pF Chip Capacitor	08051J1R0BS	AVX
C11, C12	5.6 pF Chip Capacitors	08051J5R6BS	AVX
C14	0.3 pF Chip Capacitor	ATC100B0R3BT500XT	ATC
C15	0.5 pF Chip Capacitor	ATC100B0R5BT500XT	ATC
R1, R2	5 kΩ Potentiometer CMS Cermet Multi-turn	3224W-1-502E	Bourns

 $v_{DS1} >$ 

Z1

rf Input

 $\bigcirc$ 

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V<sub>GS</sub>>









**TYPICAL CHARACTERISTICS — 2450 MHz** 



Figure 8. MTTF versus Junction Temperature

210

230





 $V_{DD}$  = 28 Vdc,  $I_{DQ1}$  = 210 mA,  $I_{DQ2}$  = 370 mA,  $P_{out}$  = 20 W CW

f	f Z <sub>source</sub> Z <sub>load</sub>	
MHz	MHz Ω Ω	
2450	54.8 + j16.6	0.42 + j4.3

 $Z_{\text{source}}$  = Test circuit impedance as measured from gate to ground.

Z<sub>load</sub> = Test circuit impedance as measured from drain to ground.



Figure 9. Series Equivalent Source and Load Impedance



## PACKAGE DIMENSIONS



## MW6IC2420NBR1



VIEW Y-Y

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	DOCUMENT NO	): 98ARH99164A	REV: M	
TO-272 WIDE BO	CASE NUMBER: 1329-09 23 AUG 20			
	STANDARD: NON-JEDEC			



NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
- 6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.
- 7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

	IN	СН	МІ	LLIMETER			INCH	М	ILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX	
Α	.100	.104	2.54	2.64	b	.011	.017	0.28	3 0.43	
A1	.038	.044	0.96	1.12	Ь1	.037	.043	0.94	l 1.09	
A2	.040	.042	1.02	1.07	b2	.037	.043	0.94	l 1.09	
D	.928	.932	23.57	23.67	bЗ	.225	.231	5.72	2 5.87	
D1	.810	BSC	20	).57 BSC	c1	.007	.011	.18	.28	
E	.551	.559	14.00	14.20	е	.054 BSC			1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.0	40 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e2	.2	24 BSC		5.69 BSC	
F	.025	BSC	0.	.64 BSC	e3	.1	50 BSC		3.81 BSC	
м	.600		15.24		r1	.063	.068	1.6	1.73	
N	.270		6.86							
					aaa		.004		.10	
© FI	© FREESCALE SEMICONDUCTOR, INC. MECHANICAL OUT				LINE	PRINT VERS	SION NC	T TO SCALE		
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	TO-272 WIDE BODY			CASE	NUMBER	R: 1329–09		23 AUG 2007		
MULTI-LEAD				STAN	DARD: NO	DN-JEDEC				

#### MW6IC2420NBR1



## **PRODUCT DOCUMENTATION**

Refer to the following documents to aid your design process.

## **Application Notes**

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- · AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN1987: Quiescent Current Control for the RF Integrated Circuit Device Family
- · AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages

## **Engineering Bulletins**

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

## **REVISION HISTORY**

The following table summarizes revisions to this document.

X	Revision	Date	Description
	0	Mar. 2007	Initial Release of Data Sheet
	1	Apr. 2008	Changed 220°C to 225°C in Capable Plastic Package bullet, p. 1
m			Added Footnote 1 to Quiescent Current Temperature bullet under Features section and to callout in Fig. 1,     Functional Block Diagram, p. 1
			Added Case Operating Temperature limit to the Maximum Ratings table and set limit to 150°C, p. 2
ш			<ul> <li>Operating Junction Temperature increased from 200°C to 225°C in Maximum Ratings table and related "Continuous use at maximum temperature will affect MTTF" footnote added, p. 2</li> </ul>
М			• Replaced Case Outline 1329-09, Issue L, with 1329-09, Issue M, p. 8-10. Added pin numbers 1 through 17.
	2	Feb. 2009	<ul> <li>Changed Storage Temperature Range in Max Ratings table from -65 to +200 to -65 to +150 for standardization across products, p. 2</li> </ul>
FET			<ul> <li>Modified data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN13232, p. 2</li> </ul>
	3	Dec. 2010	<ul> <li>Corrected data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN13232, and Product Discontinuance Notification number, PCN14260, adding applicable overlay, p. 1, 2</li> </ul>
			overlay, p. 1, 2

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Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) www.freescale.com/support

#### Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

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